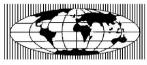
Uni-Export Instruments, s.r.o.



A MEMBER OF THE UNI-EXPORT GROU

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CENOVÁ NABÍDKA č.: IC/6001/A

Zákazník: Karlova Univerzita, Matematicko-fyzikální fakulta Ovocný trh 560/5 116 36 Praha 1

Naše značka: IC/6001

Kontaktní osoba: Prof.RNDr. Jan Kratochvíl, CSc., JUDr. Marian Polický Datum: 9.1.2019

| pol. | obj.č. | popis | ks | jednotková cena | | cena celkem | |
|------|------------------------|--|---------|-----------------|-----------|-------------|--------------------------|
| 1 | 900g - 3 (2000) | Upgrade Components | 200 000 | 3 | | | a model or propertically |
| 1 | XCK3001-0404 | Confocal Raman microscope base for the WITec alpha300 series, | 1 | Kč | 504000,00 | Kč | 504 000,00 |
| | | including: | | | | | |
| | | Optical microscope with 6x turret LED white-light source for Köhler illumination | | | | | |
| | | extensible Reflector module changer accepting filter cubes for darkfield, | | | | | |
| | | DIC or fluorescence contrast | | | | | |
| | | Motorized z-stage system for automated approach, 30mm travel, single | | | | | |
| | | step 10 nm resolution | | | | | |
| | | Implemented autofocus for local and global corrections on tilted or | | | | | |
| | | spherical surfaces | | | | | |
| | | Highly precise manual lateral sample positioning, with approx. 1 pure resolution | | | | | |
| | | Camera coupler for sample visualization incl. digital video camera | | | | | |
| _ | | | | | | | |
| 2 | XSA3101-1146 | Rigid support frame for WITec alpha300 and alpha500 microscopes, | 1 | Kč | 66000,00 | Kč | 66 000,00 |
| | | 800 mm height, 800 x 800 mm footprint. | | | | | |
| 3 | MSX3201-5010 | WITec Control FIVE, software license | 1 | Kč | 31500,00 | Kč | 31 500,00 |
| | | Instrument and experiment control software package with multi purpose | | | - | | -91 |
| | | WITec EasyLink Human Interface Device. Functionality (dependent on | | | | | |
| | | configuration): | | | | | |
| | | · EasyLink Advanced Video Control: Video Autofocus, Auto-Brightness, stepless LED Brightness slider controls | | | | | |
| | | EasyLink Movement and Focus Control: Move around the sample | | | | | |
| | | precisely using independent analogue control sticks | | | | | |
| | | · All measurement modes accessible in one comprehensive software package | | | | | |
| | | · Measurements with all installed techniques (e.g. AFM, Raman) can be | | | | | |
| | | applied, controlled simultaneously and are easily correlated | | | | | |
| | | · All essential parameters are automatically set when changing between measurement modes | | | | | |
| | | TrueScanTM for exact piezo positioning control even at the fastest scan | | | | | |
| | | rates (requires Piezo-Scanner) | | | | | |
| | | · Capability of measuring very large data sets, for e.g. image stacks | | | | | |
| | | · Automated multispot measurement sequences with the ability to execute | | | | | |
| | | complex scripts at every point | | | | | |
| | | Multi-user management including user customizable software | | | | | |
| | | configurations for individual measurement pre-configurations · Standard SPM features for AFM and SNOM | | | | | |
| | | -High speed, automatic tip approach in all AFM modes | | | | | |
| | | -Software guided step-by-step cantilever installation and adjustment | | | | | |
| | | -Oscilloscope mode for the observation of signals as a function of time | | | | | |
| | | | | | | | |
| | | | | | | | |
| | 1 | ı | | | | | ı , |

| 4 MSX3201-5000 | WITec Project FIVE, software license | 1 | Kč | 31500,00 | Kč | 31 500,00 |
|------------------|---|---|------|------------|------|--------------|
| | License includes unlimited use on multiple workstations | | | | | |
| | Functionality (dependent on configuration): | | | | | |
| | Data evaluation and processing | | | | | |
| | TrueComponent Analysis: Simple and intuitive dialoge for component based analysis of Raman measurements by representation through basis | | | | | |
| | spectra | | | | | |
| | · Wizard based guided data treatment procedures | | | | | |
| | · Various pre-configured filters and algorithms for simplified data | | | | | |
| | processing | | | | | |
| | · Filters and algorithms accessible through simple drag and drop via the | | | | | |
| | adaptive drop-action dialoge | | | | | |
| | Filter viewer: Fast and unlimited image preview generation of any filters (Peak intensity, width, position etc.) applied to a data set, also applicable | | | | | |
| | during running measurement | | | | | |
| | · Multiple algorithms for background subtraction & curve fitting (for single | | | | | |
| | spectra) | | | | | |
| | · Various statistical data evaluation options (Histrograms, Roughness | | | | | |
| | etc.) | | | | | |
| | Data export to ASCII, JCamp-DX, SPC, and MatLab feasible | | | | | |
| | Data representation | | | | | |
| | RamanTV: high speed movie-like image presentation of spectral dataset, also functional as preview option simultaneously with data acquisition | | | | | |
| | Fast determination of position, time and/or spectral correlation between | | | | | |
| | various data objects | | | | | |
| | · 2D and 3D color coded representation of any image data set (AFM, | | | | | |
| | Raman, SNOM, etc.) in selectable color schemes | | | | | |
| | Image viewer: 3D overlay of images e.g. AFM topography image with | | | | | |
| | Raman chemical information | | | | | |
| | Spectrum peak finder and labeling Easy Copy&Paste result export into external Programs for data | | | | | |
| | presentation | | | | | |
| | · Spectra export to Raman database for convenient identification of sample | | | | | |
| | components | | | | | |
| 6 XSP3000-0002 | Piezo-driven scan platform for diffraction limited confocal Raman | 1 | Kč | 1325000,00 | Kč | 1 325 000,00 |
| 0 731 3000-0002 | imaging and scanning probe microscopy with the following specifications: | 1 | IXC | 1323000,00 | IXC | 1 323 000,00 |
| | • Continuous scan range up to 200 µm in x- and y-direction, 20 µm in | | | | | |
| | zdirection | | | | | |
| | Scan hardware linearized with closed-loop feedback | | | | | |
| | • Scan resolution: position accuracy < 2 nm in x- and y-direction and | | | | | |
| | < 0.2nm in z- direction • Linearity better than 0.03% | | | | | |
| | Emounty botter than 0.0370 | | | | | |
| 7 XLP3000-0000 | Laserport for WITec Multiwavelength Coupler | 2 | Kč | 133000,00 | Kč | 266 000,00 |
| 7 2121 3000-0000 | Adds a Laserport to the Multiwavelength Coupler to connect WITec | | 100 | 133000,00 | ICC | 200 000,00 |
| | Lasermodules. Will accept WITec RayLine and RayShield technology and | | | | | |
| | includes mounting, alignment and test. | | | | | |
| | Can be selected up to three times per Multiwavelength coupler. | | | | | |
| 7 XZF3100-0532 | WITec RayLine Raman filter set for 532 nm excitation including: | 1 | Kč | 133000,00 | Kč | 133 000,00 |
| 11210100 0002 | • Long Pass Raman Filter | 1 | 120 | 100000,00 | | 100 000,00 |
| | • Laser Line Filter | | | | | |
| | Allows for measurements at approx. 90 rel. cm ⁻¹ | | | | | |
| 2 VZE2500 0622 | WITE a Day Chield Have I are European as Day on Ellan Cod | , | TZ X | 205000.00 | TZ X | 205 000 00 |
| 3 XZF3500-0633 | WITec RayShield Ultra Low Frequency Raman Filter Set for 633 nm excitation including: | 1 | Kč | 395000,00 | Kč | 395 000,00 |
| | highly precise laserfilter | | | | | |
| | · laser Cleanup filter | | | | | |
| | Allows for Stokes- and Anti-Stokes Raman measurements starting at | | | | | |
| | approx. +/- 10 rel. cm ⁻¹ | | | | | |
| | Microscopy Objectives | | | | | |
| 5 XOP3000-0001 | Set of recommended objectives for WITec alpha microscopes | 1 | Kč | 117000,00 | Kč | 117 000,00 |
| | for use in the visible spectral range | • | | 11.000,00 | | |
| | ase in the visitore spectral range | | | | | |

| 5.1 | XSO3025-0100 | Objective 10x, Zeiss EC "Epiplan" DIC , numerical aperture (NA) 0.25, working distance (WD) 11.0 mm, including an adapter ring for WITec microscope systems | 1 | | | |
|-----|--------------|--|---|----|----|--------------|
| 5.2 | XSO3025-0500 | Objective 50x, Zeiss EC "Epiplan" DIC, numerical aperture (NA) 0.75, working distance (WD) 1.0 mm, including an adapter ring for WITec microscope systems | 1 | | | |
| 5.3 | XSO3026-1000 | Objective 100x, Zeiss EC "Epiplan-Neofluar" DIC, numerical aperture (NA) 0.9, working distance (WD) 0.31 mm, excellent flatness of field for applications from 360 nm to NIR, including an adapter ring for WITec microscope systems | 1 | | | |
| | | Celkem bez DPH | | Kč | Kč | 2 869 000,00 |
| 6 | 5 | DPH 21 % | 1 | | Kč | 602 490,00 |
| | | Celkem včetně DPH | | | Kč | 3 471 490,00 |

Dodací lhůta: 2 měsíce od uzavření smlouvy.

Záruční lhůta 12 měsíců. Platnost nabídky: 60 dnů.

Platební podmínky: Platba po dodání proti faktuře se splatností 30 dnů od jejího doručení.

Bankovní spojení: ČSOB, č.ú.: 577628193/0300 CZ220300000000577628193